

N-Channel Enhancement Mode MOSFET

Feature

- 200V/130A
 R_{DS(ON)}=9.1mΩ(typ.) @ V_{GS} = 10V
- 100% Avalanche Tested
- Reliable and Rugged
- Halogen Free and Green Devices Available (RoHS Compliant)

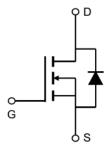
Applications

- Uninterruptible Power Supply
- Synchronous Rectification

Pin Description



TO-247A-3L



N-Channel MOSFET

Ordering and Marking Information



Package Code

W:TO-247A-3L

Date Code

XYMXXXXXX

Note: HUAYI lead-free products contain molding compounds/die attach materials and 100% matte tin plateTermi-Nation finish; which are fully compliant with RoHS. HUAYI lead-free products meet or exceed the lead-Free requirements of IPC/JEDEC J-STD-020 for MSL classification at lead-free peak reflow temperature. HUAYI defines "Green" to mean lead-free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

HUAYI reserves the right to make changes, corrections, enhancements, modifications, and improvements to this pr-oduct and/or to this document at any time without notice.



Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit	
Common Rat	tings (Tc=25°C Unless Otherwise Noted)			
VDSS	Drain-Source Voltage		200	V
Vgss	Gate-Source Voltage		±20	V
TJ	Maximum Junction Temperature		175	°C
Тѕтс	Storage Temperature Range		-55 to 175	°C
ls	Source Current-Continuous(Body Diode) Tc=25°C		130	А
Mounted on	Large Heat Sink		-	•
Ірм	Pulsed Drain Current *	Tc=25°C	470	А
1	Continuous Davis Comment	Tc=25°C	130	А
lσ	Continuous Drain Current	Tc=100°C	93	А
Б.	Maria de Branco Biologo de Composições	Tc=25°C	375	W
PD	P _D Maximum Power Dissipation Tc=100°C		187.5	W
R₀c	Thermal Resistance, Junction-to-Case		0.40	°C/W
ReJA	Thermal Resistance, Junction-to-Ambient **		40	°C/W
Eas	Single Pulsed-Avalanche Energy ***	L=0.3mH	644	mJ

Note: * Repetitive rating; pulse width limited by max. junction temperature.

** Surface mounted on FR-4 board.

*** Limited by TJmax , starting TJ=25°C, L = 0.3mH, VDS=160V, VGS =10V.

Electrical Characteristics(Tc =25°C Unless Otherwise Noted)

Cymbal	Parameter	Test Conditions	HYG100N20NS1		l loit	
Symbol	Parameter	rest Conditions	Min	Тур.	Max	Unit
Static Char	acteristics					
BVDSS	Drain-Source Breakdown Voltage	V _{GS} =0V,I _{DS} =250µA	200	-	-	V
Inco	VDS=200V,VGS=0V		-	-	1.0	μA
loss Drain-to-Source Leaka	Drain-to-Source Leakage Current	TJ=125°C	-	-	50	μA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _{DS} =250μA	2.3	3.2	3.7	V
Igss	Gate-Source Leakage Current	V_{GS} = $\pm 20V$, V_{DS} = $0V$	-	-	±100	nA
RDS(ON)*	Drain-Source On-State Resistance	V _{GS} =10V,I _{DS} =40A	-	9.1	10.7	m Ω
Diode Char	Diode Characteristics					
V _{SD} *	Diode Forward Voltage	IsD=40A,VGS=0V	-	0.83	1.3	V
trr	Reverse Recovery Time	lon=404 dlon/dt=1004/us	-	131	-	ns
Qrr	Reverse Recovery Charge	Isp=40A,dIsp/dt=100A/µs	-	693.4	-	nC

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Electrical Characteristics (Cont.) (Tc =25°C Unless Otherwise Noted)

O. made al	Parrameter.	To at Consulting	HY	HYG100N20NS1		1114
Symbol	Parameter	Parameter Test Conditions	Min	Тур.	Max	Unit
Dynamic	Characteristics					
Rg	Gate Resistance	V _{GS} =0V,V _{DS} =0V,F=1 MHz	-	4.8	-	Ω
Ciss	Input Capacitance	V _G S=0V,	-	4742	-	
Coss	Output Capacitance	V _{DS} =25V,	-	2930	-	pF
Crss	Reverse Transfer Capacitance	Frequency=1.0MHz	-	16	-	
td(ON)	Turn-on Delay Time		-	18.6	-	
Tr	Turn-on Rise Time	V_{DD} =100 V , R_{G} =2.5 Ω ,	-	94	-	
td(OFF)	Turn-off Delay Time	Ips=40A,Vgs=10V	-	63	-	ns
Tf	Turn-off Fall Time		-	83	-	
Gate Cha	Gate Charge Characteristics					
Qg	Total Gate Charge	\/ -460\/ \/ -40\/	-	65	-	
Qgs	Gate-Source Charge	V_{DS} =160V, V_{GS} =10V, I_{D} =40A	-	27	-	nC
Qgd	Gate-Drain Charge	1D-40A	-	9	-	

Note: *Pulse test, pulse width ≤ 300us, duty cycle ≤ 2%



Typical Operating Characteristics

Figure 1: Power Dissipation

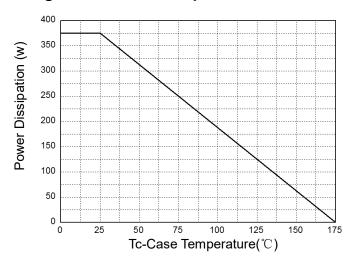


Figure 2: Drain Current

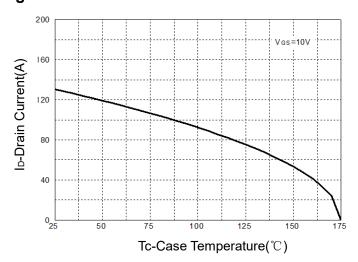


Figure 3: Safe Operation Area

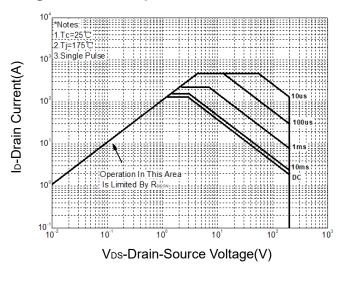
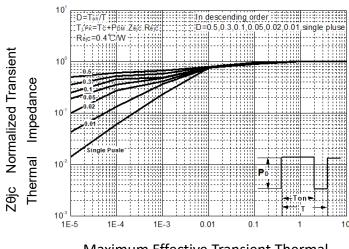


Figure 4: Thermal Transient Impedance



Maximum Effective Transient Thermal Impedance, Junction-to-Case

Figure 5: Output Characteristics

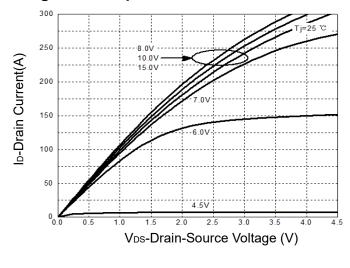
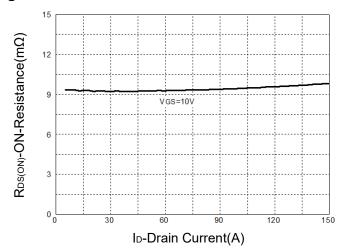


Figure 6: Drain-Source On Resistance





Typical Operating Characteristics(Cont.)

Figure 7: On-Resistance vs. Temperature

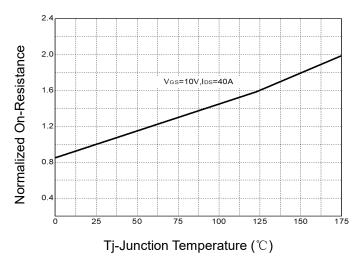


Figure 8: Source-Drain Diode Forward

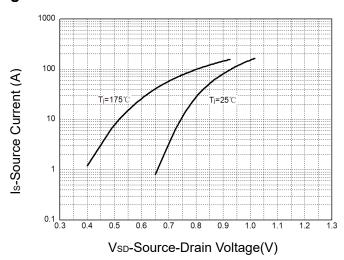


Figure 9: Capacitance Characteristics

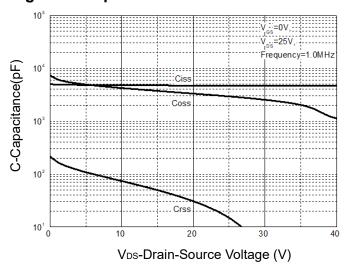
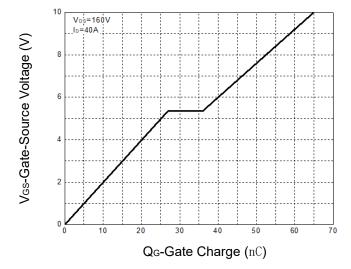
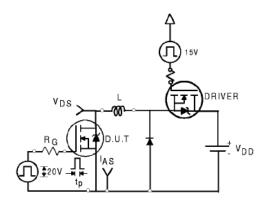


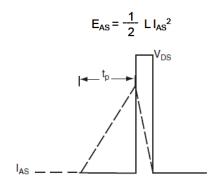
Figure 10: Gate Charge Characteristics



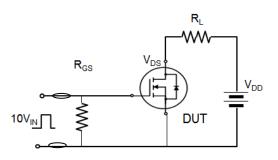


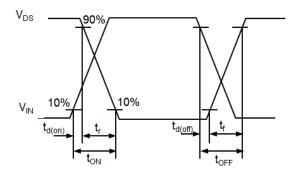
Avalanche Test Circuit



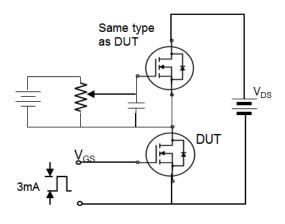


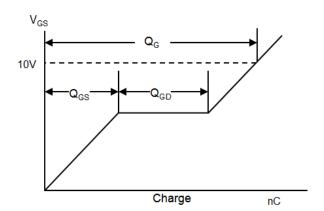
Switching Time Test Circuit





Gate Charge Test Circuit





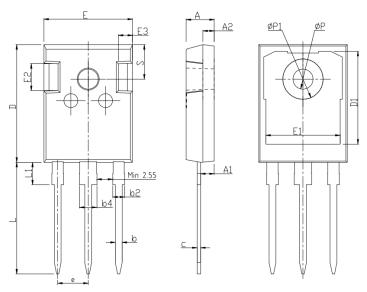


Device Per Unit

Package Type	Unit	Quantity
TO-247A-3L	Tube	30

Package Information

TO-247A-3L

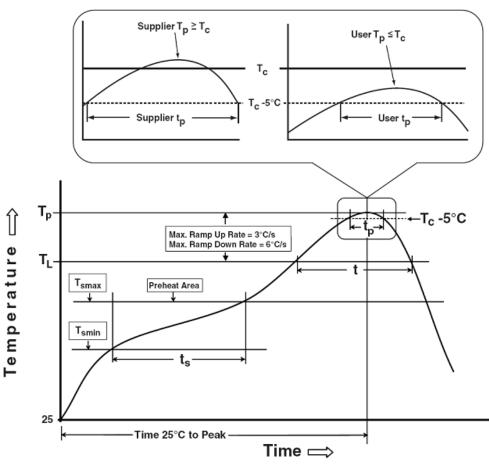


COMMON DIMENSIONS

	mm			
SYMBOL	MIN	NOM	MAX	
Α	4.80	5.00	5.20	
A1	2.21	2.41	2.61	
A2	1.85	2.00	2.15	
b	1.11	1.21	1.36	
b2	1.91	2.01	2.21	
b4	2.91	3.01	3.21	
С	0.51	0.61	0.75	
D	20.70	21.00	21.30	
D1	16.25	16.55	16.85	
E	15.50	15.80	16.10	
E1	13.00	13.30	13.60	
E2	4.80	5.00	5.20	
E3	2.30	2.50	2.70	
е	5.44BSC			
L	19.62	19.92	20.22	
L1	-		4.30	
ФР	3.40	3.60	3.80	
ФР1	-	-	7.30	
S	6.15BSC			



Classification Profile



Classification Reflow Profiles

Sn-Pb Eutectic Assembly	Pb-Free Assembly
100 °C 150 °C 60-120 seconds	150 °C 200 °C 60-120 seconds
3 °C/second max.	3°C/second max.
183 °C 60-150 seconds	217 °C 60-150 seconds
See Classification Temp in table 1	SeeClassification Tempin table 2
20** seconds	30** seconds
6 °C/second max.	6 °C/second max.
6 minutes max.	8 minutes max.
	100 °C 150 °C 60-120 seconds 3 °C/second max. 183 °C 60-150 seconds See Classification Temp in table 1 20** seconds 6 °C/second max.

^{*}Tolerance for peak profile Temperature (Tp) is defined as a supplier minimum and a user maximum.

^{**} Tolerance for time at peak profile temperature (tp) is defined as a supplier minimum and a user maximum.

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Table 1.SnPb Eutectic Process – Classification Temperatures (Tc)

Package Thickness	Volume mm³ <350	Volume mm³ ≽350
<2.5 mm	235 °C	220 °C
≥2.5 mm	220 °C	220 °C

Table 2.Pb-free Process – Classification Temperatures (Tc)

Package	Volume mm ³	Volume mm ³	Volume mm³
Thickness	<350	350-2000	≥2000
<1.6 mm	260 °C	260 °C	260 °C
1.6 mm – 2.5 mm	260 °C	250 °C	245 °C
≥2.5 mm	250 °C	245 °C	245 °C

Reliability Test Program

Test item	Method	Description
SOLDERABILITY	JESD-22, B102	5 Sec, 245°C
HTRB	JESD-22, A108	168/500/1000 Hrs, Bias @ 150°C
HTGB	JESD-22, A108	168/500/1000 Hrs, Vgs100% @ 150°C
PCT	JESD-22, A102	96 Hrs, 100%RH, 2atm, 121°C
TCT	JESD-22, A104	1000 Cycles, -55°C~150°C

Customer Service

Worldwide Sales and Service: sales@hymexa.com Technical Support: Technology@hymexa.com

Huayi Microelectronics Co., Ltd.

No.8928, Shangji Road, Economic and Technological Development Zone, Xi'an, China

TEL: (86-029) 86685706 FAX: (86-029) 86685705 E-mail: sales@hymexa.com Web net: www.hymexa.com